

## SJTU06N70C

 $I_{D}$ 

6A

D

Lead Free Package and Finish

R<sub>DS(ON)</sub>(Typ.)

0.85Ω

### Super-Junction MOSFET

#### **Applications:**

- Adaptor
- Charger
- •SMPS

#### Features:

- RoHS Compliant
- . Low ON Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- Inductive Switching Curves

#### **Ordering Information**

th Curve		G <sub>DS</sub> TO-251	G
GE	BRAND	Packages	
1	IPS	Not to Scale	Ś

Pb

 $V_{DSS}$ 

700V

# PART NUMBERPACKAGEBRANDSJTU06N70CTO-251IPS

#### Absolute Maximum Ratings T<sub>c</sub>=25°

#### $T_{C}$ =25 °C unless otherwise specified

Symbol	Parameter	SJTU06N70C	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	700	V
I <sub>D</sub>	Continuous Drain Current	6	A
I <sub>DM</sub>	Pulsed Drain Current, V <sub>GS</sub> @10V (NOTE *2)	18	Α
D	Power Dissipation	83	W
P <sub>D</sub>	Derating Factor above 25℃	0.66	<b>W/℃</b>
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy(L=10mH)	120	mJ
E <sub>AR</sub>	Avalanche Energy ,Repetitive (NOTE *2)	0.5	mJ
I <sub>AR</sub>	Avalanche Current (NOTE *2)	3	Α
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	°C

#### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units	Test Conditions
р	Junction-to-Case		1.5		Water cooled heatsink, P <sub>D</sub> adjusted for a
R <sub>θJC</sub>				°C <b>/W</b>	peak junction temperature of +150℃.
R <sub>0JA</sub>	Junction-to-Ambient		62		1 cubic foot chamber, free air.

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#### **OFF Characteristics** $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	700			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	
	Drain-to-Source Leakage Current			1		V <sub>DS</sub> =700V, V <sub>GS</sub> =0V T <sub>J</sub> =25℃	
I <sub>DSS</sub>				100	μA	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V TJ=150℃	
1	Gate-to-Source Forward Leakage			+100	<b>n</b> 4	V <sub>GS</sub> =+30V	
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -30V	

**ON Characteristics**  $T_J=25^{\circ}C$  unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R <sub>DS(ON)</sub>	StaticDrain-to-Source		0.05	0.05	0	V <sub>GS</sub> =10V, I <sub>D</sub> =3A
	On-Resistance(NOTE *3)		0.85	0.95	Ω	
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.5		4	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA
<b>g</b> <sub>fs</sub>	Forward Transconductance(NOTE *3)		5		S	V <sub>DS</sub> =8V, I <sub>D</sub> =4A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C <sub>iss</sub>	Input Capacitance		400			(1 - 0)(1) - 0(1)
C <sub>oss</sub>	Output Capacitance		46		pF	V <sub>GS</sub> = 0V,V <sub>DS</sub> = 50V f =1.0MHz
C <sub>rss</sub>	Reverse Transfer Capacitance		3			
Qg	Total Gate Charge		8			
Q <sub>gs</sub>	Gate-to-Source Charge		2		nC	I <sub>D</sub> =6A,V <sub>DD</sub> =560V V <sub>GS</sub> = 10V
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		3			

#### Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	<b>Test Conditions</b>
t <sub>d(ON)</sub>	Turn-on Delay Time		12		- ns	$V_{DD}$ =400V, I <sub>D</sub> =6A, V <sub>G</sub> =10V R <sub>G</sub> =25Ω
t <sub>rise</sub>	Rise Time		25			
t <sub>d(OFF)</sub>	Turn-Off Delay Time		36			
t <sub>fall</sub>	Fall Time		9			

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Source-Dia			11632 (		ise spe	CIIIEU	
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
1	Continuous Source Current			6	^		
IS	(Body Diode)			6	A	T <sub>c</sub> =25℃	
1	Maximum Pulsed Current			17	А	1 <sub>C</sub> -25 C	
I <sub>SM</sub>	(Body Diode)						
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	I <sub>SD</sub> =6A, V <sub>GS</sub> =0V	
t <sub>rr</sub>	Reverse Recovery Time		104		ns	I <sub>F</sub> = I <sub>S</sub>	
Q <sub>rr</sub>	Reverse Recovery Charge		0.5		uC	di/dt=100A/us	

Source-Drain Diode Characteristics Tc=25

Tc=25<sup>°</sup>C unless otherwise specified

Notes:

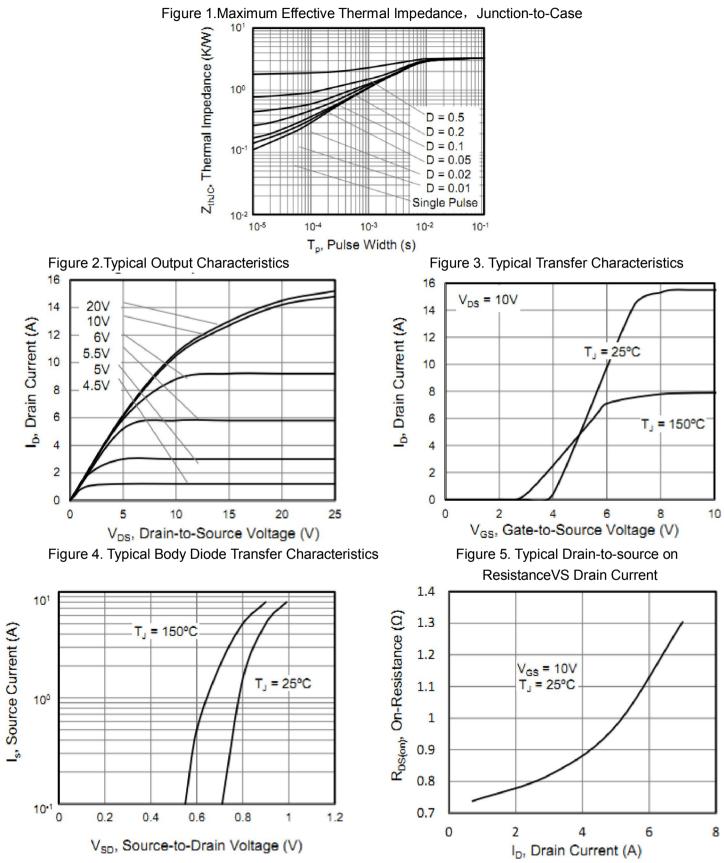
\*1. T<sub>J</sub> = +25℃ to +150℃.

\*2. Repetitive rating; pulse width limited by maximum junction temperature.

\*3. Pulse width <  $380\mu$ s; duty cycle < 2%.



#### **Characteristics Curve:**



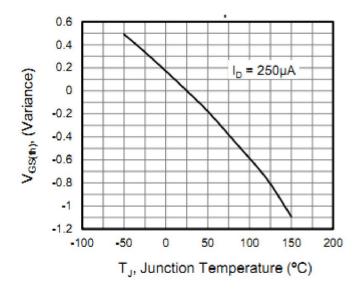
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104 Capacitance (pF) Cisa 10<sup>3</sup> Coss 102 101 C V<sub>GS</sub> = 0 = 1MHz 10<sup>0</sup> 20 30 40 0 10 50 60 70 V<sub>DS</sub>, Drain-to-Source Voltage (V)

Figure 6. Capacitance VS Drain-to-Source Voltage

Figure 8. Threshold Voltage VS Temperature



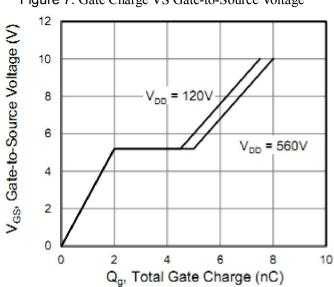


Figure 9. on-Resistance VS Temperature

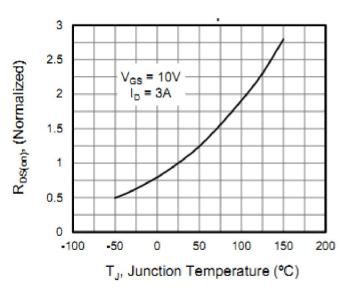
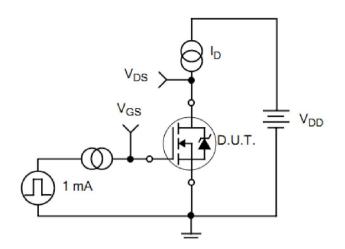


Figure 7. Gate Charge VS Gate-to-Source Voltage



#### **Test Circuits and Waveforms**



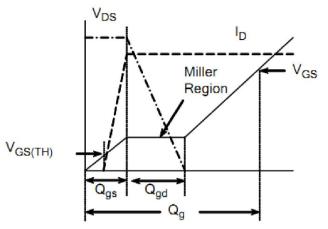


Figure 11. Gate Charge Test Circuit

Figure 12. Gate Charge Waveforms

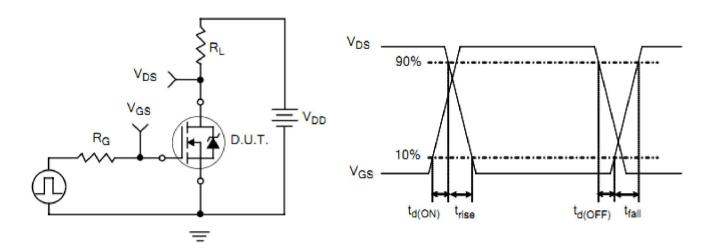
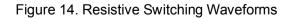
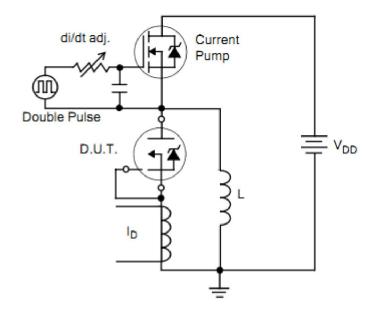


Figure 13. Resistive Switching Test Circuit







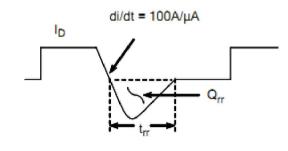


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

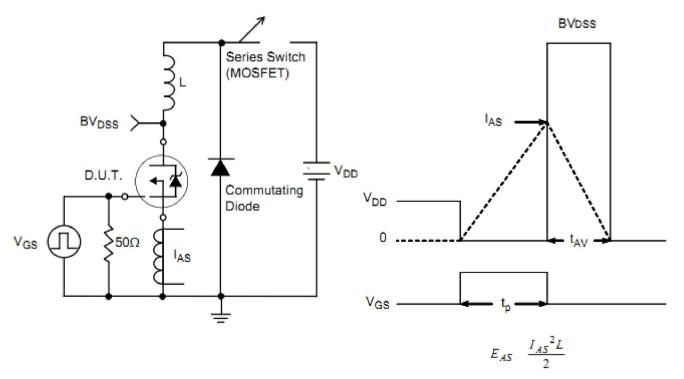


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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